

Form of Written Discussion at the 26th ITTC Conference

| Discusser: | |
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| Affiliation | DTMB-NSWCCD(USA) |
| Name of Technical Committee Resistance Committee | |

or Group to be discussed

Written Discussion (within 1,000 words of length):

Could the committee please provide definitive references to the equations that have been used to compute uncertainties (eg. resistance coefficient as in Fig. 2 and 6) and uncertainties for facility bias (eg. resistance, Fig. 3 and 7).

Response:

The equations that have been used to compute uncertainties and uncertainties for facility bias are those presented in the 24th and 25th ITTC proceedings, in which this work is based. The method and the equations are described in point 7.3 of the 25th ITTC procedures.